# Notice of References Cited Application/Control No. 08/847,967 Examiner Jon D. Epperson Applicant(s)/Patent Under Reexamination GOLDWASSER ET AL. Page 1 of 2

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*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Name	Classification
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Examiner

Jon D. Epperson

Applicant(s)/Patent Under
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GOLDWASSER ET AL.

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